## Search Notes



Application/Control	No.

10661534

Applicant(s)/Patent Under Reexamination

KATAYAMA ET AL.

Art Unit

Examiner

DEVONA E FAULK

## SEARCHED

Class	Subclass	Date	Examiner
381	105,104,106,102	3/29/07	DEF
381	311,105,104,311	9/29/07	DEF
455	41.2,420,430	4/11/08	DEF
381	102-109,311	7/28/08	DEF
455	420,430,41.2	7/28/08	DEF

## SEARCH NOTES

Search Notes	Date	Examiner	
Assignee/Inventor Search	3/29/07	DEF	
combined class/word search 381/102-109	3/29,31/07	DEF	
Additional search	9/29/07	DEF	
Reviewed applicant's arguments; maintained rejection	4/11/08	DEF	
Additional search	4/11/08	DEF	
Consulted with Nghi Han Ly of class 455, suggested 455/41.2,420 and 430	4/11/08	DEF	
additional search	7/28/08	DEF	

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
381	104-106,102	3/29/07	DEF
455	41.2,420,430	4/11/08	DEF

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